## Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

## Listing of Claims:

- 1. (Currently amended) A multi-stack optical data storage medium (20)—for rewritable recording using a focused radiation beam (19) entering through an entrance face (16)—of the medium (20)—during recording, comprising:
  - [[-]] a substrate (1)—with deposited on a side thereof:
- [[-]] a first recording stack  $\frac{(2)}{L_0}$  comprising a first phase-change type recording layer— $\frac{(6)}{(6)}$ , said first recording stack  $\frac{(2)}{(2)}$  being present at a position most remote from the entrance face  $\frac{(16)}{(16)}$ ,
- [[-]] at least one further recording stack  $\frac{(3)}{L_n}$ , which comprises a further phase-change type recording layer  $\frac{(12)}{L_n}$ , being present closer to the entrance face  $\frac{(16)}{L_n}$  than the first recording stack  $\frac{(2)}{L_n}$ ,
- [[-]] a transparent spacer layer  $\frac{(9)}{}$  between the recording stacks  $\frac{(2, 3)}{}$ , said transparent spacer  $\frac{(9)}{}$  layer having a thickness

larger than the depth of focus of the focused laser-light beam (19),

characterized in thatwherein the further recording layer (12) is substantially of an alloy defined by the formula  $Ge_xSb_yTe_z$  in atomic percentages, where 0<x<15, 50<y<80, 10<z<30 and x+y+z=100 with a thickness selected from the range of 4 to 12 nm and that at least one transparent crystallization promoting layer  $(11^1, 13^1)$  having a thickness smaller than 5 nm is present in contact with the further recording layer—(12), wherein the first recording stack and the further recording stack have the same atomic percentages of compounds.

- 2. (Currently amended) An The optical storage medium (20) as claimed in claim 1, wherein the transparent crystallization promoting layer (11', 13') mainly comprises a material selected from the group of nitrides, oxides of Si, Al and Hf.
- 3. (Currently amended) An The optical storage medium (20) as claimed in claim 2, wherein the transparent crystallization promoting layer (11', 13') mainly comprises a material selected from the group of nitrides of Al and nitrides of Si.

- 4. (Currently amended) An The optical storage medium  $\frac{(20)}{}$  as claimed in claim 2, wherein the further recording layer  $\frac{(12)}{}$  has a thickness selected from the range of 4 to 8 nm.
- 5. (Currently amended) An The optical storage medium  $\frac{(20)}{(20)}$  as claimed claim 1, wherein the alloy has a composition defined by the formula  $Ge_xSb_yTe_z$  in atomic percentages, where 5<x<8, 70<y<80, 15<z<20 and x+y+z=100.
- 6. (Currently amended) An The optical storage medium  $\frac{(20)}{(20)}$  as claimed in any one of claims 1, wherein a metal reflective layer  $\frac{(14)}{(14)}$ , semi-transparent for the radiation beam  $\frac{(19)}{(19)}$ , is present in the further recording stack  $\frac{(3)}{(19)}$ .
- 7. (Currently amended) An The optical storage medium  $\frac{(20)}{}$  as claimed in claims 6, wherein the metal reflective layer  $\frac{(14)}{}$  mainly comprises the element Cu.

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Amendment in Reply to Final Office Action of August 5, 2008

- 8. (Currently amended) Use of an optical storage medium (20) as claimed in claim 1, for high speed recording with a recording speed higher than  $12\ m/s$ .
- 9. (New) The optical storage medium as claimed in claim 1, wherein the first recording stack and the further recording stack have the same composition.
- 10. (New) The optical storage medium as claimed in claim 1, wherein the first recording stack and the further recording stack have the composition  $Ge_7Sb_{76.4}Te_{16.6}$ .